

RF Exposure Report

Report No.: SA170417E07

FCC ID: JNZCU0017

Test Model: C-U0017

Received Date: Apr. 17, 2017

Test Date: June 21 to 27, 2017

Issued Date: July 04, 2017

Applicant: LOGITECH FAR EAST LTD.

Address: #2 Creation Rd. 4, Science-Based Ind. Park Hsinchu Taiwan, R.O.C.

Issued By: Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch

Hsin Chu Laboratory

Lab Address: E-2, No.1, Li Hsin 1st Road, Hsinchu Science Park, Hsinchu City 300,

Taiwan R.O.C.





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Release Control Record

Issue No.	Description	Date Issued
SA170417E07	Original release.	July 04, 2017



Certificate of Conformity 1

Product: USB Transceiver

Brand: Logitech

Test Model: C-U0017

Sample Status: ENGINEERING SAMPLE

Applicant: LOGITECH FAR EAST LTD.

Test Date: June 21 to 27, 2017

Standards: FCC Part 2 (Section 2.1093)

KDB 447498 D01 General RF Exposure Guidance v06

IEEE C95.1-1992

The above equipment has been tested by Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Prepared by :	Cindy	HSIN	_ ,	Date:	July 04, 2017
	Cindy Hsin / S	Specialist			
Approved by :	May Chen / I	Manager	_ ,	Date:	July 04, 2017



2 Evaluation Result

Following FCC KDB 447498 D01 "General SAR test exclusion guidance"

The corresponding SAR Exclusion Threshold condition, listed below:

1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] $\cdot [\sqrt{f(GHz)}] \le 3.0$ for 1-g SAR and ≤ 7.5 for 10-g extremity SAR, where

- f(GHz) is the RF channel transmit frequency in GHz.
- Power and distance are rounded to the nearest mW and mm before calculation.
- ➤ The result is rounded to one decimal place for comparison The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.</p>
- 2) At 100 MHz to 6 GHz and for test separation distances > 50 mm, the SAR test exclusion threshold is determined according to the following:
 - a) [Threshold at 50 mm in step 1) + (test separation distance 50mm)·(f(MHz)/150)] mW, at 100MHz to 1500 MHz
 - b) [Threshold at 50 mm in step 1) + (test separation distance 50 mm)·10] mW at > 1500 MHz and ≤ 6 GHz
- 3) At frequencies below 100 MHz, the following may be considered for SAR test exclusion.
 - a) The threshold at the corresponding test separation distance at 100 MHz in step 2) is multiplied by [1 + log(100/f(MHz))] for test separation distances > 50 mm and < 200 mm.
 - b) The threshold determined by the equation in a) for 50 mm and 100 MHz is multiplied by $\frac{1}{2}$ for test separation distances \leq 50 mm.
 - c) SAR measurement procedures are not established below 100 MHz. When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any test results to be acceptable.



3 SAR Test Exclusion Thresholds

Frequency (MHz)	Field Strength of Fundamental (dBuV/m)	Pout EIRP (dBm)	Pout EIRP (mW)	Min. test separation distance (mm)	SAR test exclusion calculation value ^(NOTE 1)	10-g extremity SAR test exclusion thresholds	Result
433.92	92.3	-2.93	0.5093	5	0.0671	7.5	Pass

NOTE: 1. The antenna type is Chip antenna with 0.83dBi gain.

- 2. Calculate SAR test exclusion thresholds from condition "1" formulas.
- 3. Pout EIRP (dBm) = Field Strength of Fundamental (dBuV/m) 95.23 (dB)

4 Conclusion

Since Source-base time average power is below SAR test exclusion power thresholds, the SAR evaluation is not required.

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